

FEATURES

■ Access time : 55 ns

■ Low power consumption: Operating current: 30 mA (TYP.) Standby current: 4 µA (TYP.) ■ Single 2.7V ~ 5.5V power supply

■ All outputs TIL compatible

■ Fully static operation

■ Tri-state output

■ Data retention voltage :1.5V(MIN.)

All products ROHS Compliant

■ Package: 32-pin 450 mil SOP;32-pin 600 mil P-DIP

32-pin 8mm x 20mm TSOP-I 32-pin 8mm x 13.4mm STSOP 36-ball 6mm x 8mm TFBGA 32-pin 400 mil TSOP-II

GENERAL DESCRIPTION

The AS6C4008 is a 4,194,304-bit low power CMOS static random access memory organized as 524,288 words by 8 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

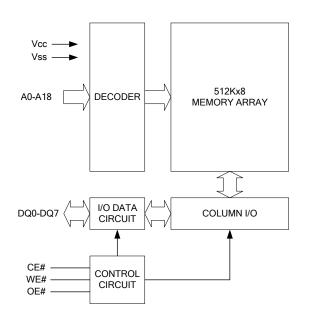
The AS6C4008 is well designed for very low power system applications, and particularly well suited for battery back-up non-volatile memory application.

The AS6C4008 operates from a single power supply of $2.7V\sim5.5V$ and all inputs and outputs are fully TIL compatible

PRODUCT FAMILY

Product	Operating	Vcc Range	Speed -	Power D	issipation
Family	Temperature	vcc range	Speed	Standby(IsB1TYP.)	Operating(Icc,TYP.)
AS6C4008	-40 ~ +85 °C	2.7 ~ 5.5V	55ns	4µA(LL)	30mA

FUNCTIONAL BLOCK DIAGRAM

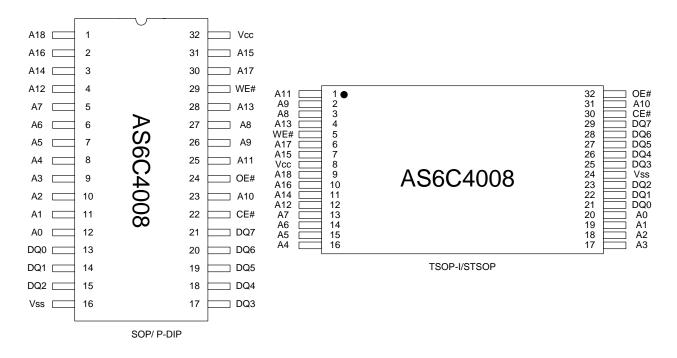


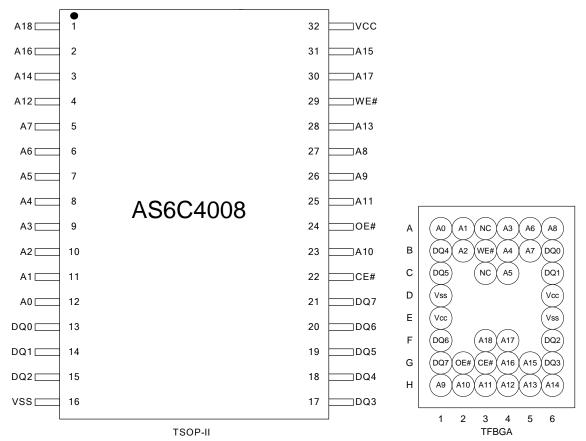
PIN DESCRIPTION**

SYMBOL	DESCRIPTION
A0 - A18	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
CE#	Chip Enable Inputs
WE#	Write Enable Input
OE#	Output Enable Input
Vcc	Power Supply
Vss	Ground
NC	No Connection



PIN CONFIGURATION





ABSOLUTE MAXIMUM RATINGS*

PARAMETER	SYMBOL	RATING	UNIT	
Terminal Voltage with Respect to Vss	VTERM	-0.5 to 6.5	V	
Operating Temperature	TA	0 to 70(C grade)	60	
Operating remperature	IA IA	-40 to 85(I grade)	Co	
Storage Temperature	Тѕтс	-65 to 150	Со	
Power Dissipation	PD	1	W	
DC Output Current	Іоит	50	mA	
Soldering Temperature (under 10 sec)	Tsolder	260	Co	

^{*}Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

TRUTH TABLE

MODE	CE#	OE#	WE#	I/O OPERATION	SUPPLY CURRENT
Standby	Н	Х	Х	High-Z	I _{SB1}
Output Disable	L	Н	Н	High-Z	Icc,Icc1
Read	L	L	Н	Dout	lcc,lcc1
Write	L	Х	L	Din	Icc,Icc1

Note: H = VIH, L = VIL, X = Don't care.

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP. *3	MAX.	UNIT
Supply Voltage	Vcc			2.7	3.0	5.5	V
Input High Voltage	V _{IH} *1			0.7*Vcc	-	Vcc+0.3	V
Input Low Voltage	V _{IL} *1			- 0.2	-	0.6	V
Input Leakage Current	ILI	$V_{CC} \ge V_{IN} \ge V_{SS}$		- 1	-	1	μΑ
Output Leakage Current	ILO	$V_{CC} \ge V_{OUT} \ge V_{SS},$ Output Disabled		- 1	-	1	μA
Output High Voltage	Vон	Iон = -1mA		2.4	-	=	V
Output Low Voltage	Vol	I _{OL} = 2mA		=	-	0.4	V
Average Operating		Cycle time = Min. CE# = 0.2V, I_{VO} = 0mA other pins at 0.2V or V_{CC} - 0.2V	55	. <u>-</u>	30	60	mA
Power supply Current	Icc1	Cycle time = 1μ s CE# = 0.2V, I_{VO} = 0mA other pins at 0.2V or V_{CC} - 0.2V		-	4	10	mA
Standby Power Supply Current	I _{SB1}	CE# ≧Vcc - 0.2V -LLE/	/-LLI	-	4	50 ^{*4} 50 ^{*4}	μA μA

Notes: 1. VIH(max) = Vcc + 3.0V for pulse width less than 10ns. VIL(min) = Vss - 3.0V for pulse width less than 10ns.

- 2. Over/Undershoot specifications are characterized, not 100% tested.
 - 3. Typical values are included for reference only and are not guaranteed or tested.
 - Typical valued are measured at Vcc = Vcc(TYP.) and Ta = 25?
 - 4. $25\mu A$ for special request

CAPACITANCE (TA = 25°C, f = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	Cin	-	6	pF
Input/Output Capacitance	C _{I/O}	-	8	pF

Note: These parameters are guaranteed by device characterization, but not production tested.

AC TEST CONDITIONS

Input Pulse Levels	0.2V to Vcc - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	$C_L = 30pF + 1TTL$, $I_{OH}/I_{OL} = -2mA/4mA$

AC ELECTRICAL CHARACTERISTICS

(1) READ CYCLE

PARAMETER	SYM.	AS6C4008-55		UNIT	
		MIN.	MAX.		
Read Cycle Time	trc	55	-	ns	
Address Access Time	taa	-	55	ns	
Chip Enable Access Time	tace	-	55	ns	
Output Enable Access Time	toe	-	30	ns	
Chip Enable to Output in Low-Z	tcLz*	10	-	ns	
Output Enable to Output in Low-Z	tolz*	5	-	ns	
Chip Disable to Output in High-Z	tcHz*	-	20	ns	
Output Disable to Output in High-Z	tonz*	-	20	ns	
Output Hold from Address Change	tон	10	-	ns	

(2) WRITE CYCLE

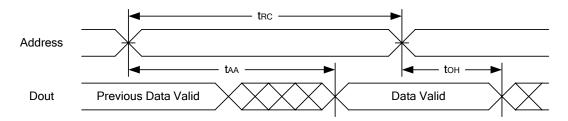
PARAMETER	SYM.	AS6C4	AS6C4008-55		
		MIN.	MAX.		
Write Cycle Time	twc	55	-	ns	
Address Valid to End of Write	taw	50	-	ns	
Chip Enable to End of Write	tcw	50	-	ns	
Address Set-up Time	tas	0	-	ns	
Write Pulse Width	twp	45	-	ns	
Write Recovery Time	twr	0	-	ns	
Data to Write Time Overlap	tow	25	-	ns	
Data Hold from End of Write Time	tон	0		ns	
Output Active from End of Write	tow*	5	-	ns	
Write to Output in High-Z	twnz*	-	20	ns	

^{*}These parameters are guaranteed by device characterization, but not production tested.

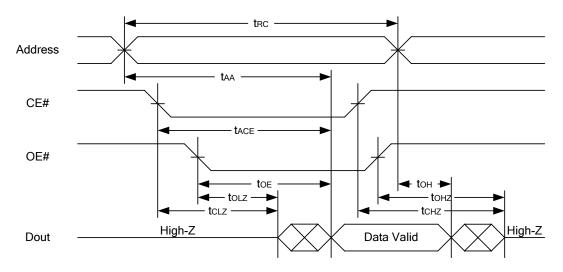


TIMING WAVEFORMS

READ CYCLE 1 (Address Controlled) (1,2)



READ CYCLE 2 (CE# and OE# Controlled) (1,3,4,5)

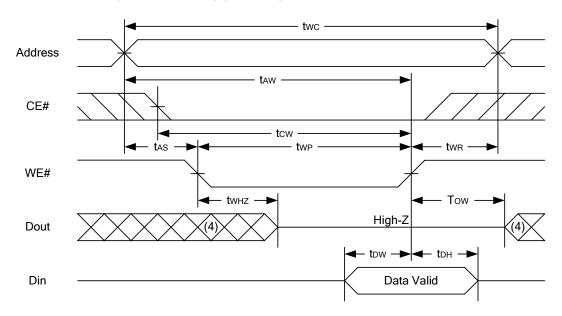


Notes:

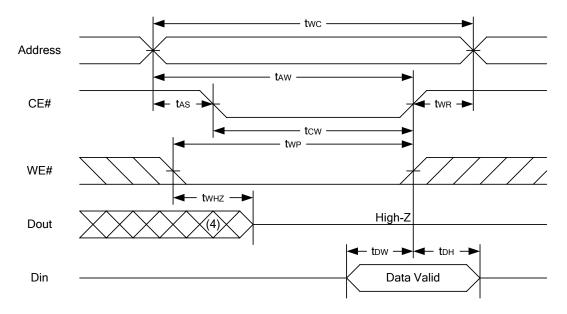
- 1.WE# is high for read cycle.
- 2.Device is continuously selected OE# = low, CE# = low.
- 3.Address must be valid prior to or coincident with CE# = low,; otherwise tAA is the limiting parameter.
- 4.tclz, tolz, tchz and tohz are specified with CL = 5pF. Transition is measured ±500mV from steady state.
- $5. At any given temperature and voltage condition, t_{CHZ} is less than t_{CLZ} \ , t_{OHZ} is less than t_{OLZ}. \\$



WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



WRITE CYCLE 2 (CE# Controlled) (1,2,5,6)



Notes

- 1.WE#, CE# must be high during all address transitions.
- 2.A write occurs during the overlap of a low CE#, low WE#.
- 3.During a WE# controlled write cycle with OE# low, twp must be greater than twHz + tpw to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE# low transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
- 6.tow and twHz are specified with CL = 5pF. Transition is measured $\pm 500mV$ from steady state.

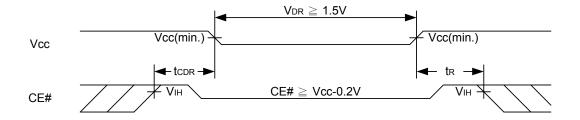


DATA RETENTION CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Vcc for Data Retention	V _{DR}	CE# ≥ V _{CC} - 0.2V		1.5	-	5.5	V
Data Retention Current		1.00	·LL	-	2	30	μA
Bata Netention Current	IDK	CE# ≧ Vcc - 0.2V -	·LLE/-LLI	-	2	30	μA
Chip Disable to Data Retention Time	tcdr	See Data Retention Waveforms (below)		0	-	-	ns
Recovery Time	tr			t RC∗	-	-	ns

tRC∗ = Read Cycle Time

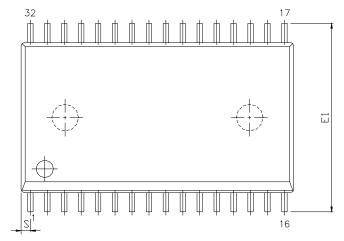
DATA RETENTION WAVEFORM

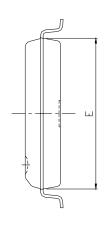


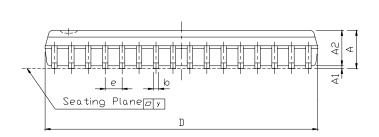


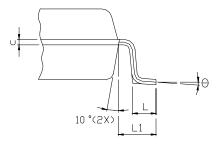
PACKAGE OUTLINE DIMENSION

32 pin 450 mil SOP Package Outline Dimension





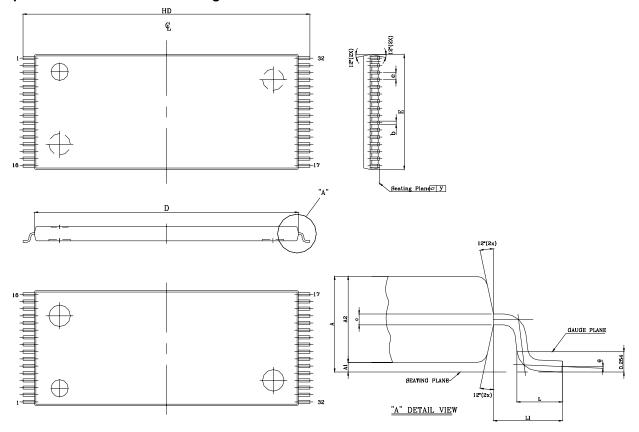




SYM. UNIT	INCH.(BASE)	MM(REF)
Α	0.118 (MAX)	2.997 (MAX)
A1	0.004(MIN)	0.102(MIN)
A2	0.111(MAX)	2.82(MAX)
b	0.016(TYP)	0.406(TYP)
С	0.008(TYP)	0.203(TYP)
D	0.817(MAX)	20.75(MAX)
Е	0.445 ±0.005	11.303 ±0.127
E1	0.555 ±0.012	14.097 ±0.305
е	0.050(TYP)	1.270(TYP)
L	0.0347 ±0.008	0.881 ±0.203
L1	0.055 ±0.008	1.397 ±0.203
S	0.026(MAX)	0.660 (MAX)
у	0.004(MAX)	0.101(MAX)
Θ	0° -10°	0° -10°



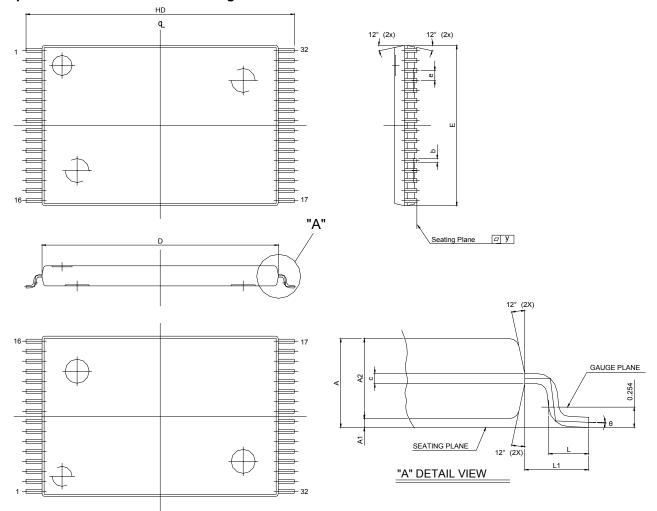
32 pin 8mm x 20mm TSOP-I Package Outline Dimension



SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.047 (MAX)	1.20 (MAX)
A1	0.004 ±0.002	0.10 ±0.05
A2	0.039 ±0.002	1.00 ±0.05
b	0.008 + 0.002 - 0.001	0.20 + 0.05 -0.03
С	0.005 (TYP)	0.127 (TYP)
D	0.724 ±0.004	18.40 ±0.10
E	0.315 ±0.004	8.00 ±0.10
е	0.020 (TYP)	0.50 (TYP)
HD	0.787 ±0.008	20.00 ±0.20
L	0.0197 ±0.004	0.50 ±0.10
L1	0.0315 ±0.004	0.08 ±0.10
у	0.003 (MAX)	0.076 (MAX)
Θ	0°∼5°	0°∼5°



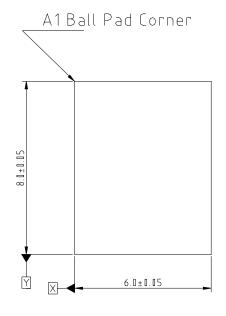
32 pin 8mm x 13.4mm STSOP Package Outline Dimension

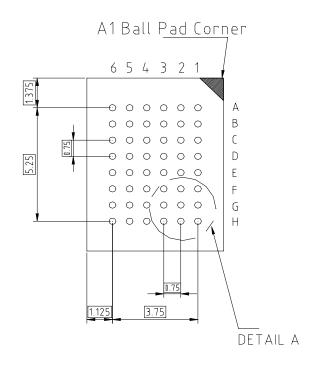


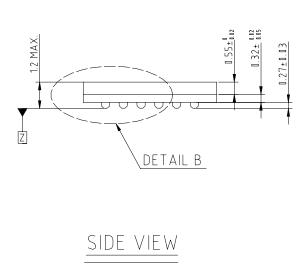
SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.049 (MAX)	1.25 (MAX)
A1	0.005 ±0.002	0.130 ±0.05
A2	0.039 ±0.002	1.00 ±0.05
b	0.008 ±0.01	0.20±0.025
С	0.005 (TYP)	0.127 (TYP)
D	0.465 ±0.004	11.80 ±0.10
E	0.315 ±0.004	8.00 ±0.10
е	0.020 (TYP)	0.50 (TYP)
HD	0.528±0.008	13.40 ±0.20.
L	0.0197 ±0.004	0.50 ±0.10
L1	0.0315 ±0.004	0.8 ±0.10
у	0.003 (MAX)	0.076 (MAX)
Θ	0°∼5°	0°~5°

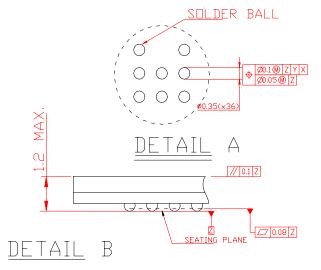


36 ball 6mm × 8mm TFBGA Package Outline Dimension



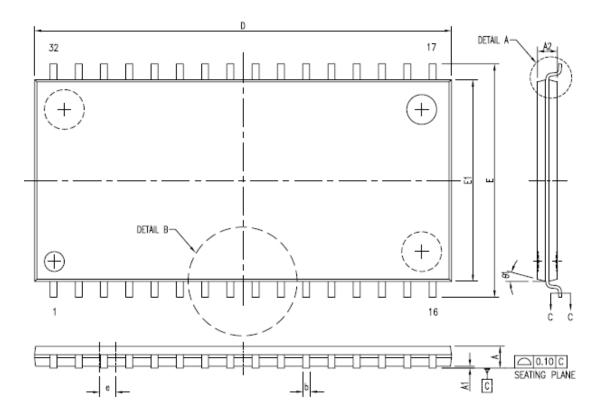


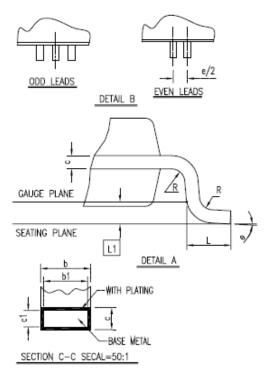






32-pin 400mil TSOP-II Package Outline Dimension



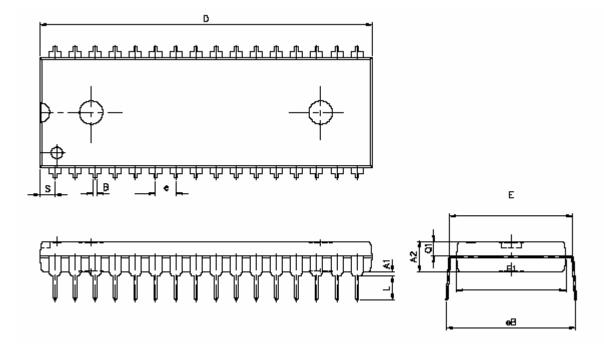


cylinos	DIMENSION IN MM			DIMENSION IN INCH		
SYMBOL	MIN.	MOM	MAX.	MIN.	NOM	MAX.
Α			1.20			0.047
A1	0.05		0.15	0.002		0.006
A2	0.95	1.00	1.05	0.037	0.039	0.041
С	0.12		0.21	0.005		0.008
c1	0.12	0.15	0.18	0.005	0.006	0.007
D	20.82	20.95	21.08	0.820	0.825	0.830
E	11.56	11.76	11.96	0.455	0.463	0.471
E1	10.03	10.16	10.29	0.395	0.400	0.405
L	0.40	0.50	0.60	0.016	0.020	0.024
L1	0.25 BASIC			0.010 BASIC		
R	0.11		0.25	0.004		0.010
θ	0		5	0		5
91	10	15	20	10	15	20

N	32L					
е	1.27 BASIC					
Ь	0.30		0.52			
ь1	0.30	0.40	0.45			
JEDEC	MS-024(BA)					



32 pin 600 mil P-DIP Package Outline Dimension



UNIT SYM.	INCH(BASE)	MM(REF)	
A1	0.001 (MIN)	0.254 (MIN)	
A2	0.150 ± 0.005	3.810 ± 0.127	
В	0.018 ± 0.005	0.457 ± 0.127	
D	1.650 ± 0.005	41.910 ± 0.127	
E	0.600 ± 0.010	15.240 ± 0.254	
E1	0.544 ± 0.004	13.818 ± 0.102	
е	0.100 (TYP)	2.540 (TYP)	
eВ	0.640 ± 0.020	16.256 ± 0.508.	
L	0.130 ± 0.010	3.302 ± 0.254	
S	0.075 ± 0.010	1.905 ± 0.254	
Q1	0.070 ± 0.005	1.778 ± 0.127	

Note: D/E1/S dimension do not include mold flash.



ORDERING INFORMATION

				Operating	Speed
Alliance	Organization	VCC	Package	Temp	ns
				Commercial ~	
AS6C4008-55PCN	512k x 8	5V	32pin 600mil DIP	0° C to 70° C	55
				Industrial ~	
AS6C4008-55SIN	512k x 8	5V	32pin 450mil SOP	-40°C to 85° C	55
				Industrial ~	
AS6C4008-55TIN	512k x 8	5V	32pin TSOP 1 (8 x 20 mm)	-40°C to 85° C	55
				Industrial ~	
AS6C4008-55STIN	512k x 8	5V	32pin sTSOP (8 x 13.4 mm)	-40°C to 85° C	55
				Industrial ~	
AS6C4008-55BIN	512k x 8	5V	36pin TFBGA (6mm x 8mm)	-40°C to 85° C	55
				Industrial ~	
AS6C4008-55ZIN	512k x 8	5V	32-pin 400mil TSOP 11	-40°C to 85° C	55

PART NUMBERING SYSTEM

AS6C	4008	- 55	X	X	N
			Package Options: P = 32 pin 600 mil P-DIP		
			S = 32 pin 450 mil SOP	Temperature Range:	
low	Device		T = 32 pin TSOP 1 (8mm x 20 mm)	C = Commercial	N = Lead
power	Number		Z = 32-pin 400mil TSOP 11	(0°C to +70° C)	Free ROHS
SRAM	40 = 4M	Access	ST = 32 pin sTSOP (8mm x 13.4 mm)	I = Industrial	Compliant
prefix	<mark>08</mark> = by 8	Time	B = 36 pin TFBGA (6mm x 8mm)	(-40° to +85° C)	Part